

Hot-Swap Controller IC Makes Adjustable Circuit Breaker

Use of a hot-swap controller IC provides inrush-current-limiting and circuit-breaker functions for medium to high-voltage circuit protection.

Medium- and high-voltage systems that range from 9V to 72V often require one or more of the following circuit capabilities: hot-swap control, circuit-breaker fault protection, and inrush current limiting.

The circuit of Figure 1 provides inrush current limiting and a reliable circuit-breaker function for the load (C1 and R2), yet contains only a p-channel MOSFET, a hot-swap controller IC, and two optional resistors (R1 and R3). Adding a low-value resistor at the MOSFET drain provides an adjustable trip-point and improved accuracy over the operating temperature range (Figure 2).

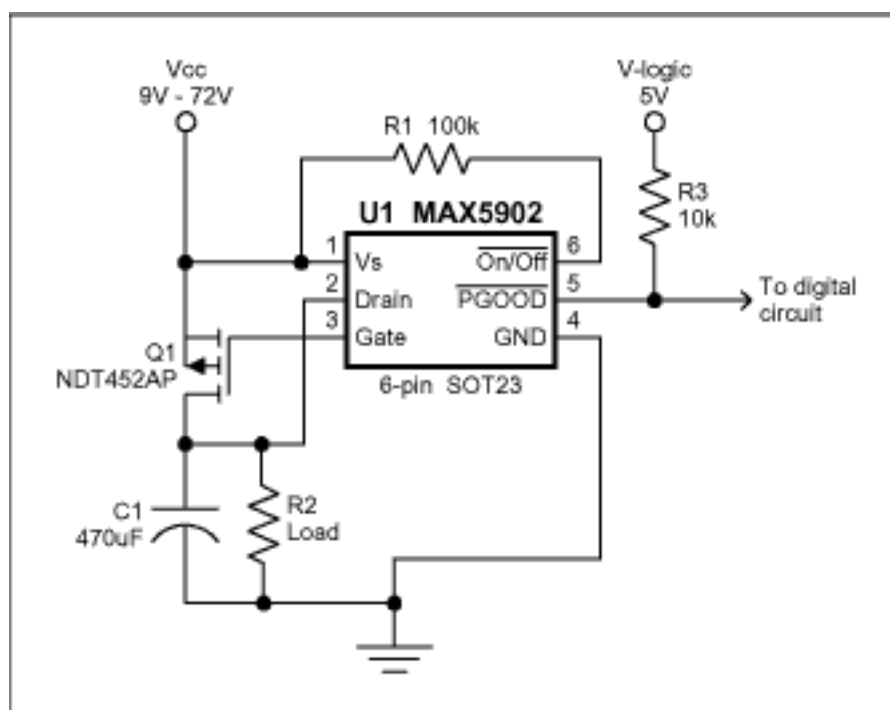


Figure 1. Standard circuit-breaker application.

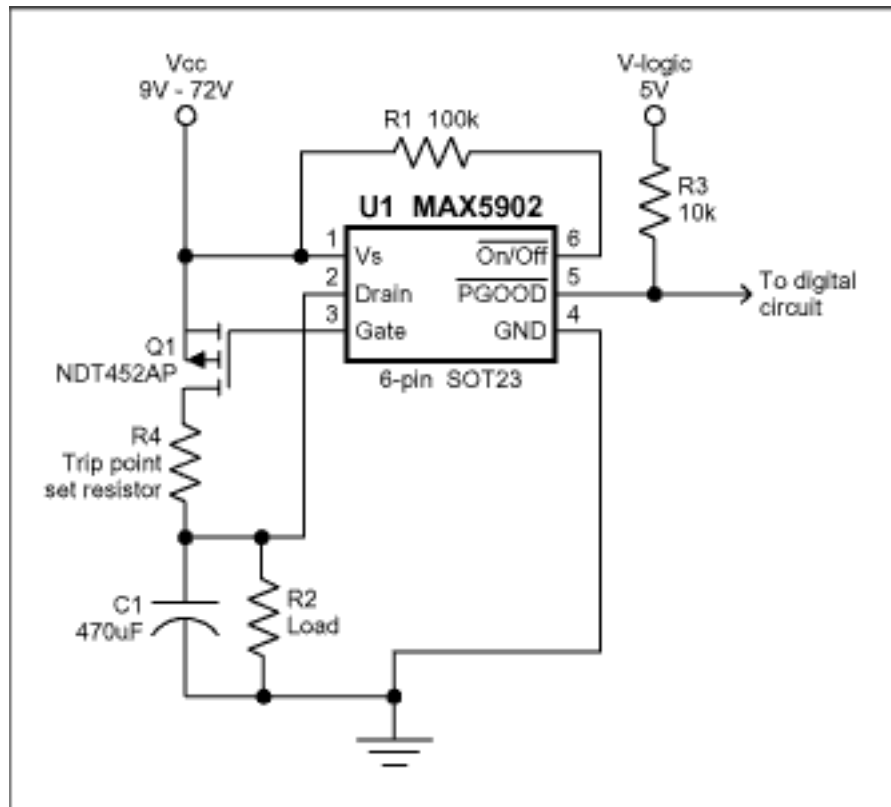


Figure 2. Adding a trip-point-adjust resistor (R4) to the circuit of Figure 1 improves its initial accuracy and accuracy over temperature.

For hot-swap applications, U1 limits the inrush current based on a typical gate-drive slew rate of 9V/mS. Inrush current is given by the equation $I = C dV/dT = CSR$, where C = load capacitance and SR is the slew rate, set by U1 at 9V/mS (typical). For a load capacitance of 100μF, the IC limits inrush current to approximately 0.9A.

U1's circuit-breaker function uses an internal comparator and the MOSFET on-resistance ($R_{DS(ON)}$) to sense a fault condition. ($R_{DS(ON)}$) for Q1 is typically 52mΩ and U1 has selectable circuit-breaker trip points (CB) of 300mV, 400mV, or 500mV. At the lowest trip point (300mV), the CB trip current at $T_J = 25^\circ C$ is typically 5.77A.

The circuit breaker's voltage-trip value is determined from the equation $V_{CB} > (R_{DS(ON)}) I_{LOAD(MAX)}$, or $V_{CB}/I_{LOAD(MAX)} > (R_{DS(ON)})$.

Suppose the desired limit is 2A. Using typical values,

$$300mV/2A \approx 150m\Omega > (R_{DS(ON)}).$$

Instead of substituting another MOSFET with higher on-resistance, add a $\approx 100m\Omega$ resistor in series with Q1 (i.e., R4 in Figure 2). Besides allowing adjustable circuit-breaker levels, R4 provides better circuit-breaker accuracy and improved stability over temperature. For example, ($R_{DS(ON)}$) for Q1 is $\approx 52m\Omega$ @ $T_J = 25^\circ C$ and $\approx 130m\Omega$ @ $T_J = 125^\circ C$, a change of 150%. If you

add a 100m Ω , 100ppm/ $^{\circ}$ C resistor (which varies by 0.001 Ω from 25 $^{\circ}$ C to 125 $^{\circ}$ C), the combined variance from 25 $^{\circ}$ C (152m Ω) to 125 $^{\circ}$ C (231m Ω) is only 79m Ω , which is 52%.

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More Information

MAX5902: [QuickView](#) -- [Full \(PDF\) Data Sheet](#) -- [Free Samples](#)